

# FIG. 1

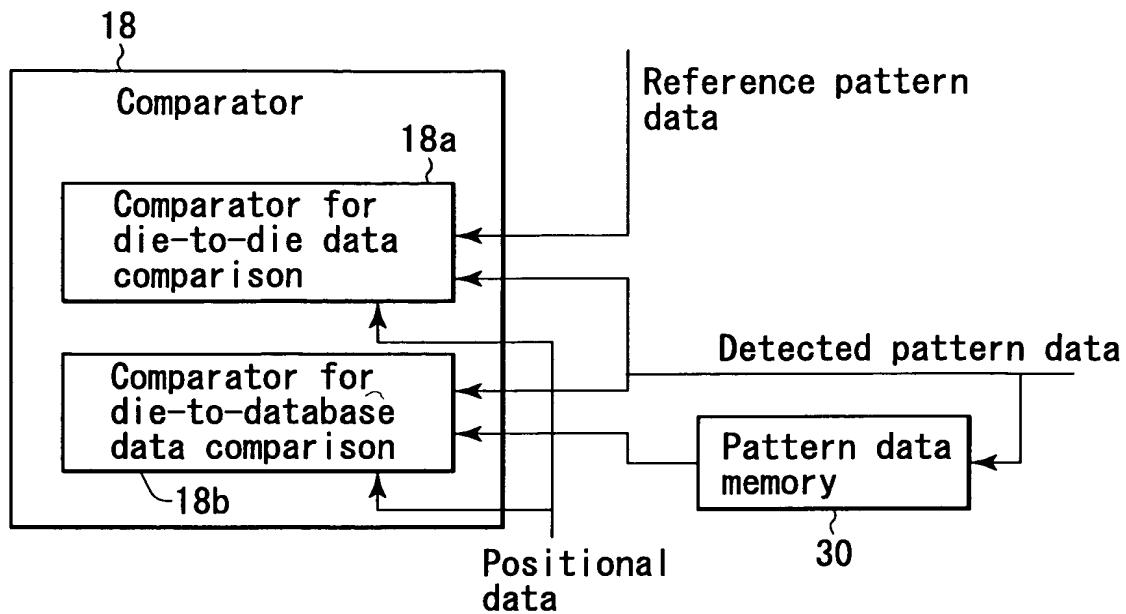


FIG. 2

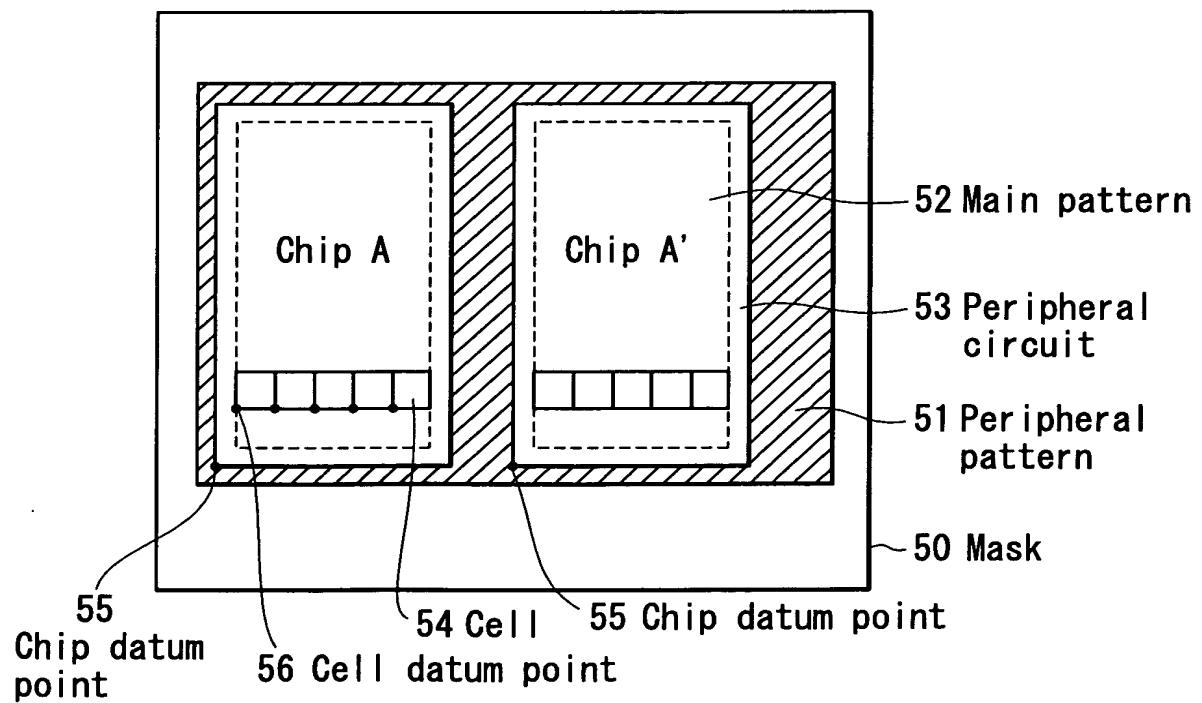


FIG. 3

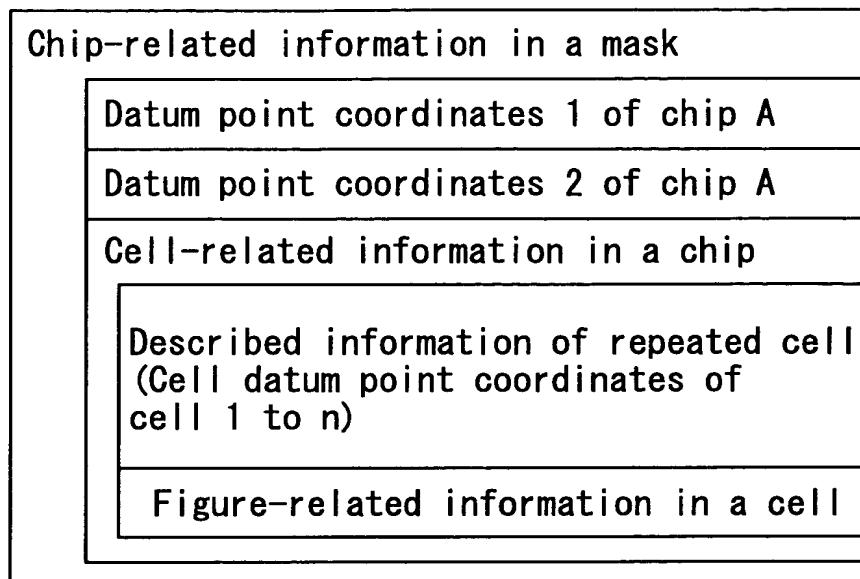


FIG. 4

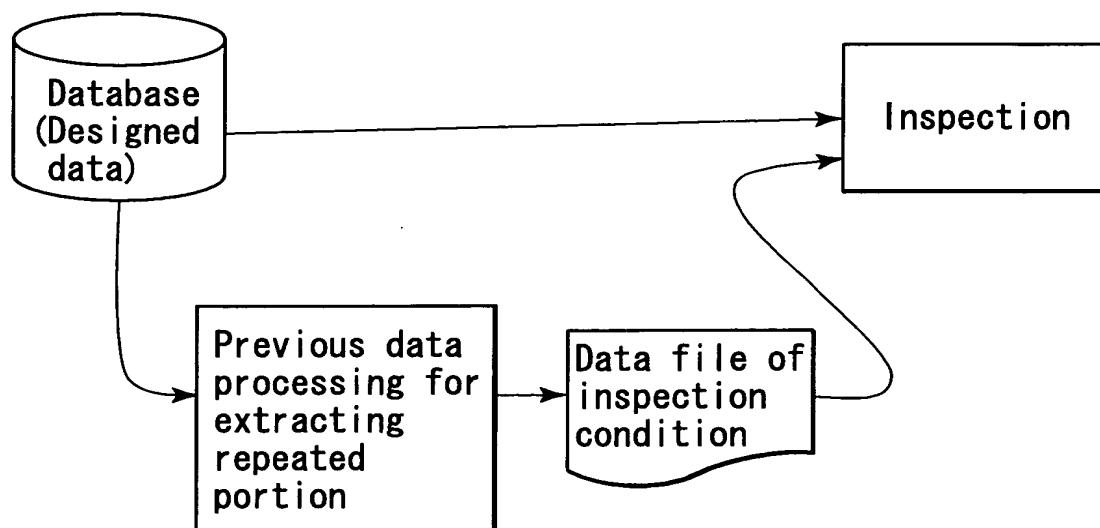


FIG. 5

Inspection data item:  
Threshold level of defect or not  
Discrimination condition a:  
Discrimination condition b:  
Discrimination condition c:  
Illumination method of  
transmitted/reflected light:  
Magnification mode of optics in inspection  
Alignment-related information  
: : : :  
Inspection mode of die-to-die combined  
with die-to-database (ON/OFF)  
Start point coordinates of die 1(x1, y1) :  
Finish point coordinates of die 1(x2, y2) :  
Start point coordinates of die 2(x3, y3) :  
Finish point coordinates of die 2(x4, y4) :

FIG. 6

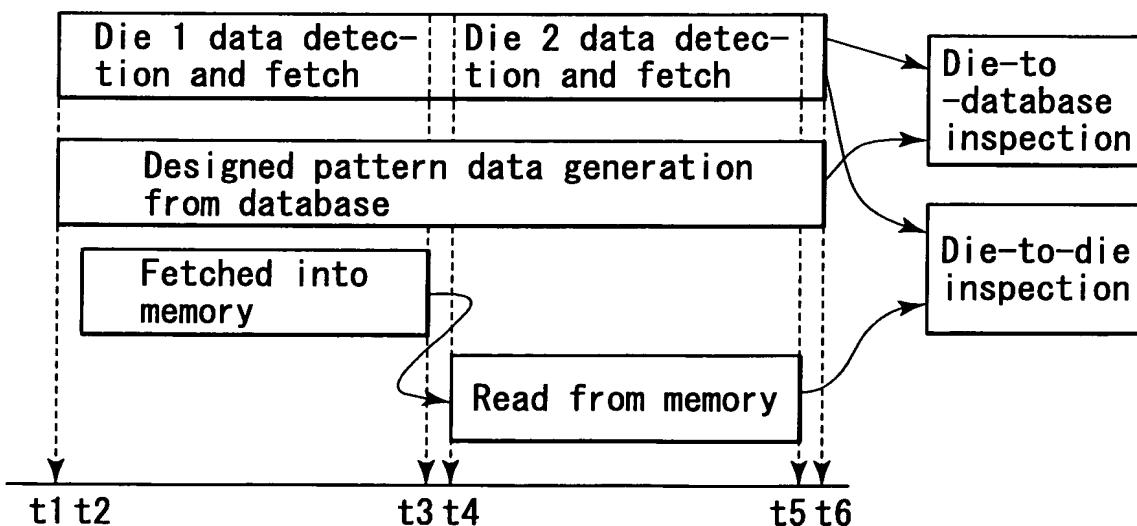


FIG. 7

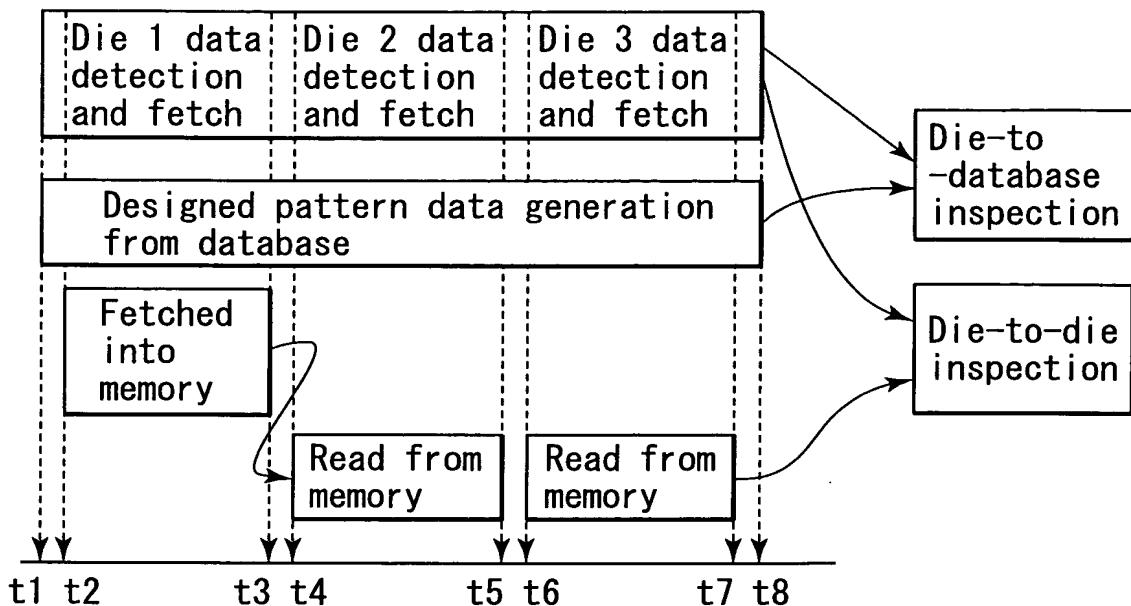


FIG. 8

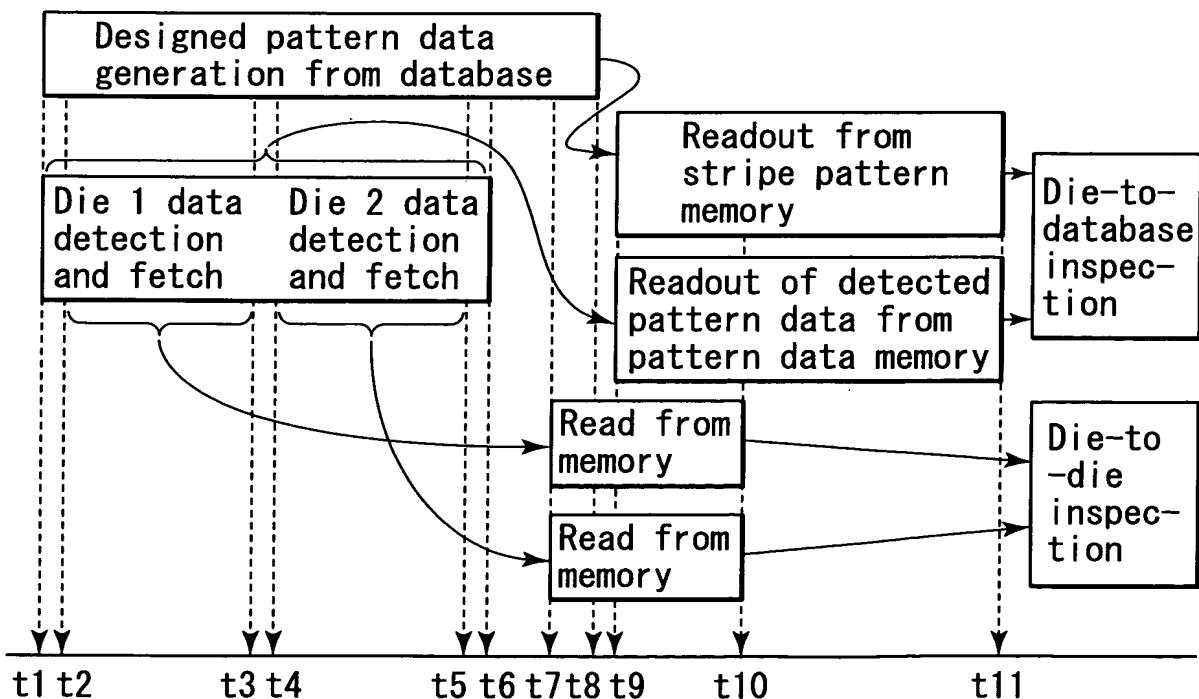


FIG. 9

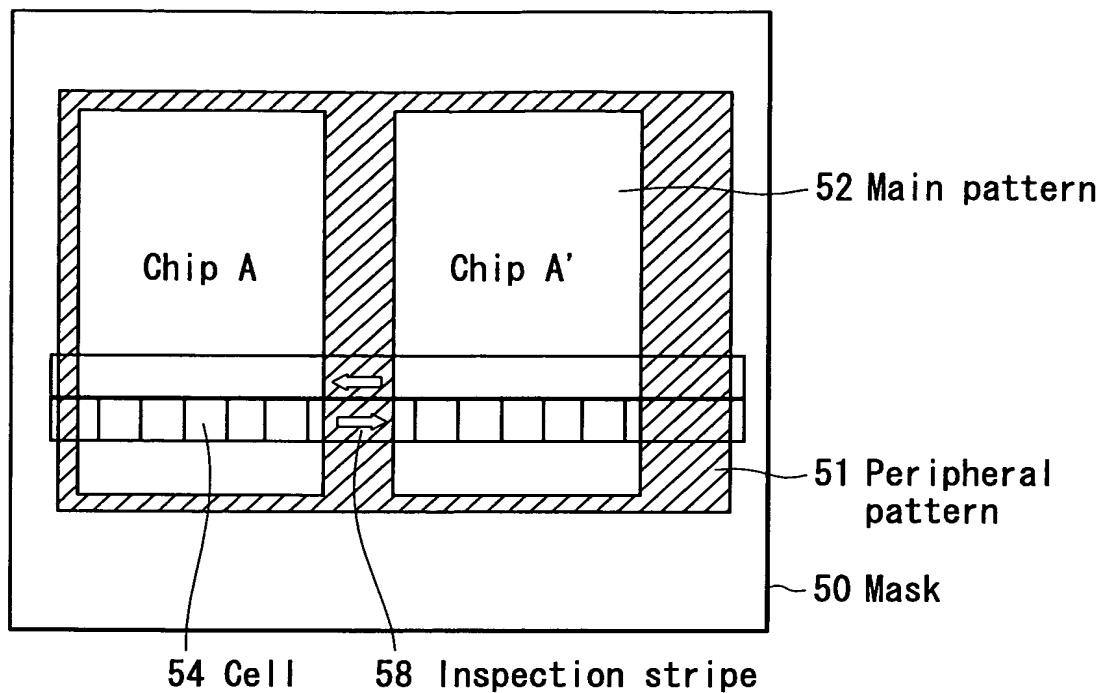


FIG. 10

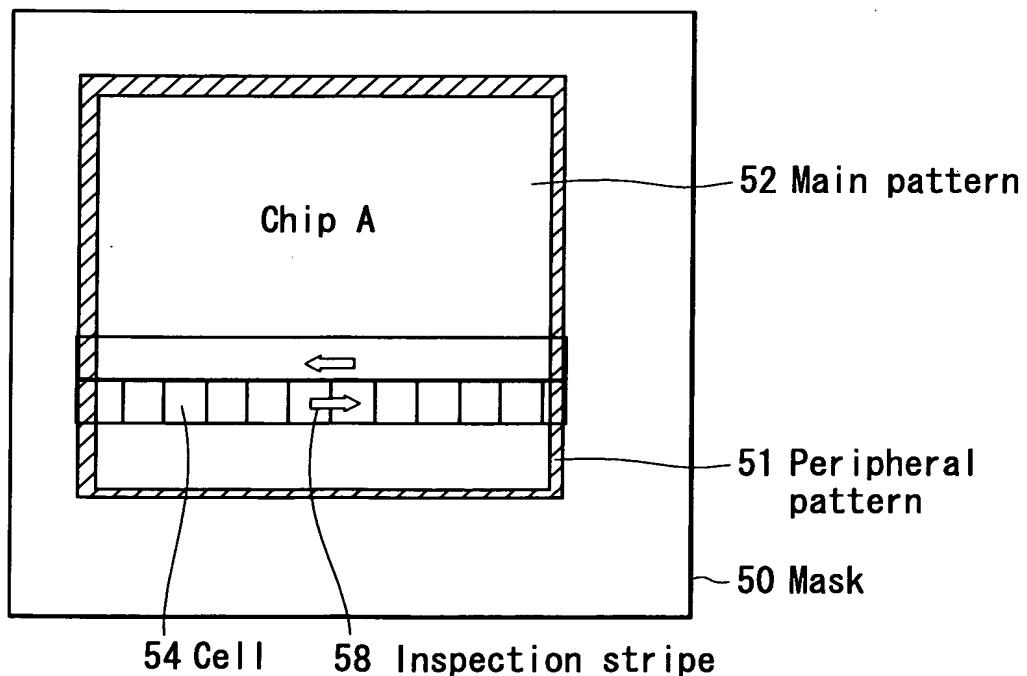


FIG. 11

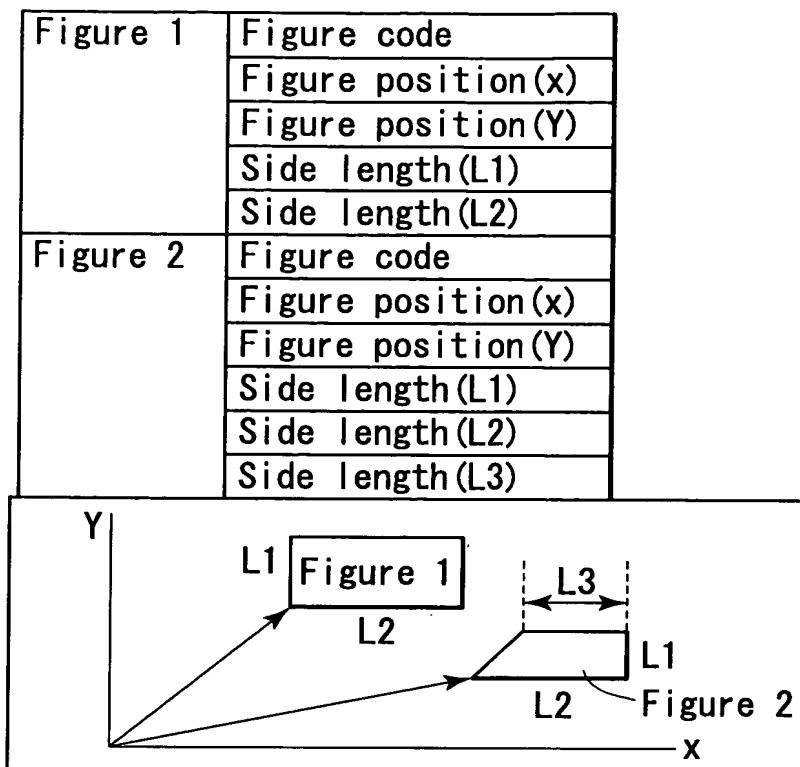


FIG. 12

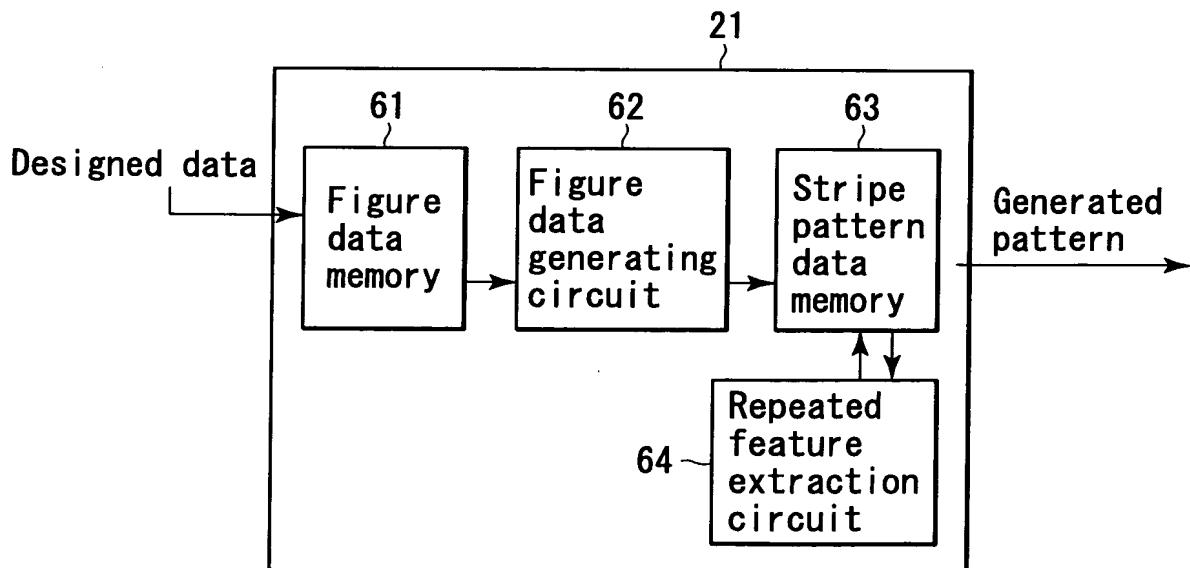


FIG. 13

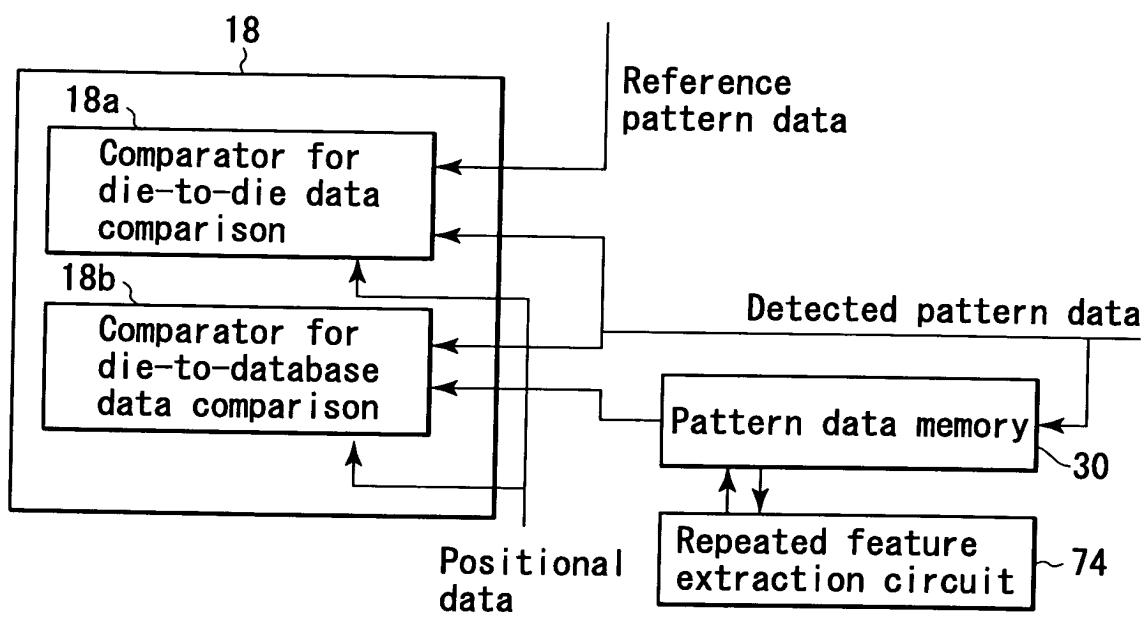


FIG. 14

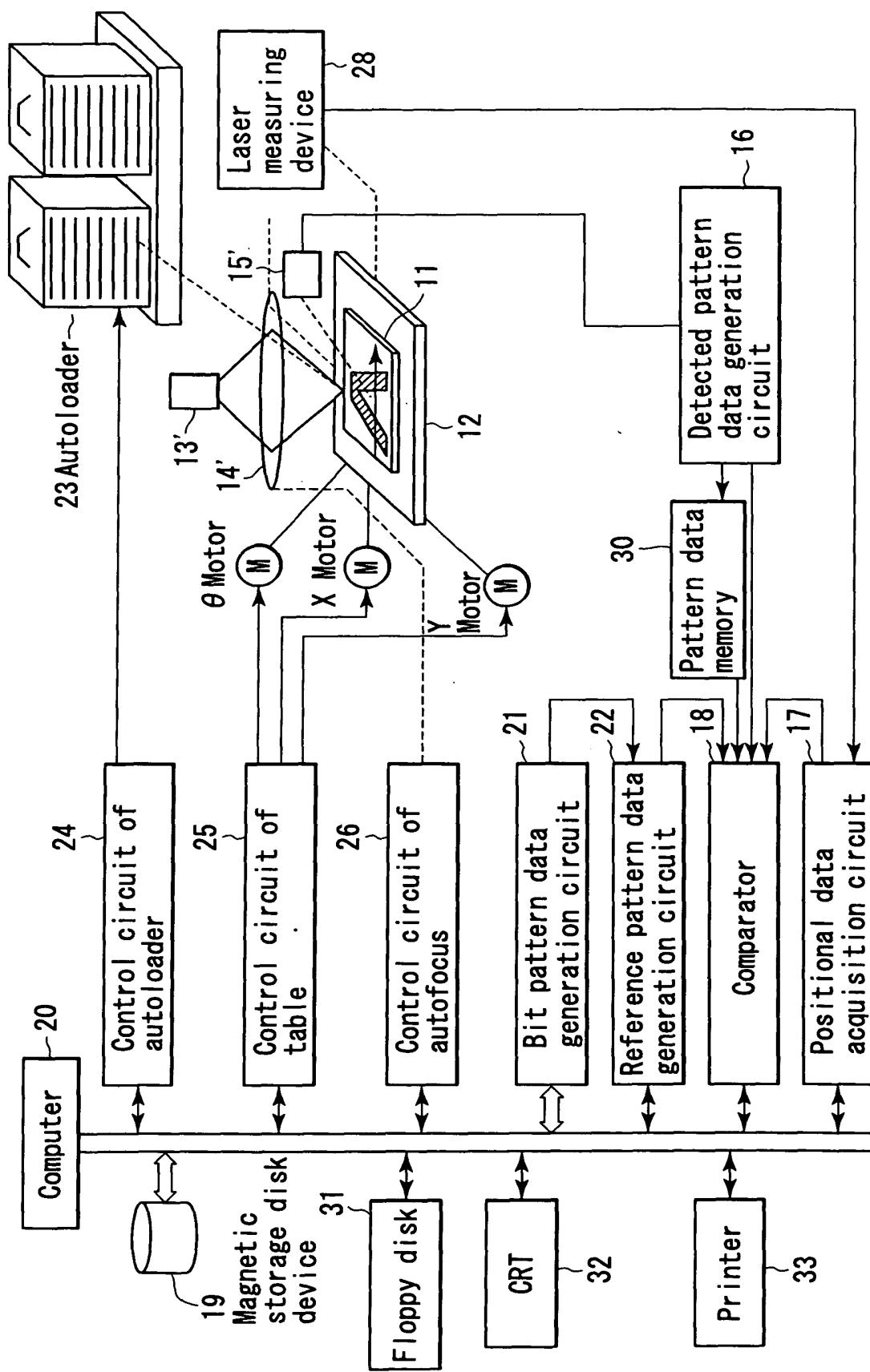


FIG. 15